

### General Description

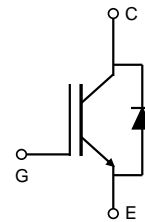
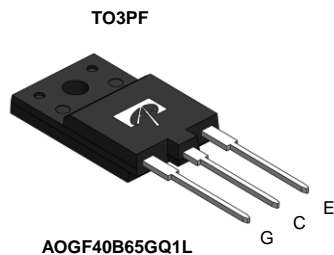
- 650V breakdown voltage
- Very high switching speed
- Low turn-off switching loss and softness
- Very good EMI behavior
- Latest AlphaIGBT technology
- Very fast and soft recovery freewheeling diode

### Applications

- Power factor correction
- High frequency resonant converters

### Product Summary

$V_{CE}$	650V
$I_C$ ( $T_C=100^\circ\text{C}$ )	40A
$V_{CE(sat)}$ ( $T_J=25^\circ\text{C}$ )	1.85V



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOGF40B65GQ1L	TO3PF	Tube	480

#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	AOGF40B65GQ1L	Units
Collector-Emitter Voltage	$V_{CE}$	650	V
Gate-Emitter Voltage	$V_{GE}$	$\pm 30$	V
Continuous Collector Current	$I_C$	$T_C=25^\circ\text{C}$	80 <sup>(1)</sup>
		$T_C=100^\circ\text{C}$	40 <sup>(1)</sup>
Pulsed Collector Current, Limited by $T_{Jmax}$	$I_{CM}$	120	A
Turn-Off SOA, $V_{CE} \leq 650\text{V}$ , Limited by $T_{Jmax}$	$I_{LM}$	120	A
Continuous Diode Forward Current	$I_F$	$T_C=25^\circ\text{C}$	20 <sup>(1)</sup>
		$T_C=100^\circ\text{C}$	10 <sup>(1)</sup>
Diode Pulsed Current, Limited by $T_{Jmax}$	$I_{FM}$	30	A
Power Dissipation	$P_D$	$T_C=25^\circ\text{C}$	63
		$T_C=100^\circ\text{C}$	25
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ\text{C}$
Maximum Lead Temperature for Soldering Purpose, 1/8" from case for 5 seconds	$T_L$	300	$^\circ\text{C}$

#### Thermal Characteristics

Parameter	Symbol	AOGF40B65GQ1L	Units
Maximum Junction-to-Ambient	$R_{\theta JA}$	30	$^\circ\text{C/W}$
Maximum IGBT Junction-to-Case	$R_{\theta JC}$	2	$^\circ\text{C/W}$
Maximum Diode Junction-to-Case	$R_{\theta JC}$	4.5	$^\circ\text{C/W}$

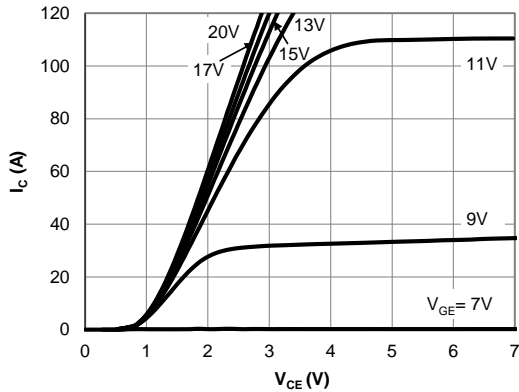
(1) TO3PF  $I_C, I_F$  follows TO247.

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

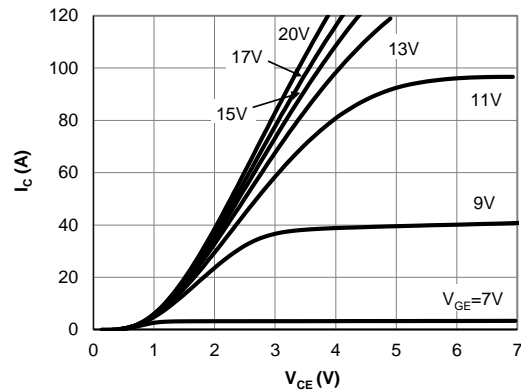
Symbol	Parameter	Conditions	Min	Typ	Max	Units	
<b>STATIC PARAMETERS</b>							
BV <sub>CES</sub>	Collector-Emitter Breakdown Voltage	I <sub>C</sub> =1mA, V <sub>GE</sub> =0V, T <sub>J</sub> =25°C	650	-	-	V	
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> =40A	T <sub>J</sub> =25°C	-	1.85	2.4	V
			T <sub>J</sub> =125°C	-	2.11	-	
			T <sub>J</sub> =150°C	-	2.19	-	
V <sub>F</sub>	Diode Forward Voltage	V <sub>GE</sub> =0V, I <sub>F</sub> =10A	T <sub>J</sub> =25°C	-	1.65	2.1	V
			T <sub>J</sub> =125°C	-	1.76	-	
			T <sub>J</sub> =150°C	-	1.73	-	
V <sub>GE(th)</sub>	Gate-Emitter Threshold Voltage	V <sub>CE</sub> =5V, I <sub>C</sub> =1mA	-	6	-	V	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	V <sub>CE</sub> =650V, V <sub>GE</sub> =0V	T <sub>J</sub> =25°C	-	-	10	μA
			T <sub>J</sub> =125°C	-	-	500	
			T <sub>J</sub> =150°C	-	-	1000	
I <sub>GES</sub>	Gate-Emitter Leakage Current	V <sub>CE</sub> =0V, V <sub>GE</sub> =±30V	-	-	±100	nA	
g <sub>FS</sub>	Forward Transconductance	V <sub>CE</sub> =20V, I <sub>C</sub> =40A	-	29	-	S	
<b>DYNAMIC PARAMETERS</b>							
C <sub>ies</sub>	Input Capacitance	V <sub>GE</sub> =0V, V <sub>CC</sub> =25V, f=1MHz	-	2565	-	pF	
C <sub>oes</sub>	Output Capacitance		-	65	-	pF	
C <sub>res</sub>	Reverse Transfer Capacitance		-	45	-	pF	
Q <sub>g</sub>	Total Gate Charge	V <sub>GE</sub> =15V, V <sub>CC</sub> =520V, I <sub>C</sub> =40A	-	86	-	nC	
Q <sub>ge</sub>	Gate to Emitter Charge		-	24	-	nC	
Q <sub>gc</sub>	Gate to Collector Charge		-	35	-	nC	
R <sub>g</sub>	Gate Resistance	V <sub>GE</sub> =0V, V <sub>CC</sub> =0V, f=1MHz	-	0.8	-	Ω	
<b>SWITCHING PARAMETERS, (Load Inductive, T<sub>J</sub>=25°C)</b>							
t <sub>D(on)</sub>	Turn-On Delay Time	T <sub>J</sub> =25°C V <sub>GE</sub> =15V, V <sub>CC</sub> =400V, I <sub>C</sub> =20A, R <sub>g(on)</sub> =7.5Ω, R <sub>g(off)</sub> =47Ω	-	25.5	-	ns	
t <sub>r</sub>	Turn-On Rise Time		-	17	-	ns	
t <sub>D(off)</sub>	Turn-Off Delay Time		-	344	-	ns	
t <sub>f</sub>	Turn-Off Fall Time		-	28	-	ns	
E <sub>on</sub>	Turn-On Energy		-	0.44	-	mJ	
E <sub>off</sub>	Turn-Off Energy		-	0.43	-	mJ	
E <sub>total</sub>	Total Switching Energy		-	0.87	-	mJ	
t <sub>rr</sub>	Diode Reverse Recovery Time	T <sub>J</sub> =25°C I <sub>F</sub> =10A, di/dt=200A/μs, V <sub>CC</sub> =400V	-	100	-	ns	
Q <sub>rr</sub>	Diode Reverse Recovery Charge		-	0.24	-	μC	
I <sub>rm</sub>	Diode Peak Reverse Recovery Current		-	3.9	-	A	
<b>SWITCHING PARAMETERS, (Load Inductive, T<sub>J</sub>=150°C)</b>							
t <sub>D(on)</sub>	Turn-On Delay Time	T <sub>J</sub> =150°C V <sub>GE</sub> =15V, V <sub>CC</sub> =400V, I <sub>C</sub> =20A, R <sub>g(on)</sub> =7.5Ω, R <sub>g(off)</sub> =47Ω	-	24	-	ns	
t <sub>r</sub>	Turn-On Rise Time		-	18	-	ns	
t <sub>D(off)</sub>	Turn-Off Delay Time		-	392	-	ns	
t <sub>f</sub>	Turn-Off Fall Time		-	26	-	ns	
E <sub>on</sub>	Turn-On Energy		-	0.5	-	mJ	
E <sub>off</sub>	Turn-Off Energy		-	0.54	-	mJ	
E <sub>total</sub>	Total Switching Energy		-	1.04	-	mJ	
t <sub>rr</sub>	Diode Reverse Recovery Time	T <sub>J</sub> =150°C I <sub>F</sub> =10A, di/dt=200A/μs, V <sub>CC</sub> =400V	-	142	-	ns	
Q <sub>rr</sub>	Diode Reverse Recovery Charge		-	0.45	-	μC	
I <sub>rm</sub>	Diode Peak Reverse Recovery Current		-	4.9	-	A	

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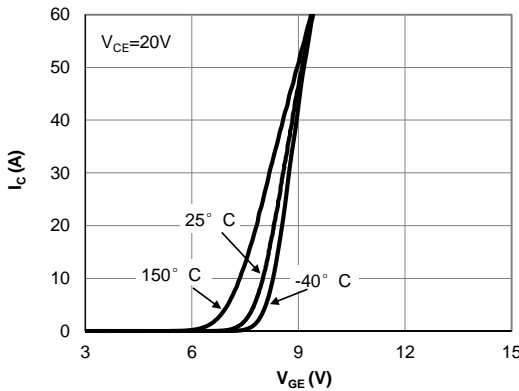
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



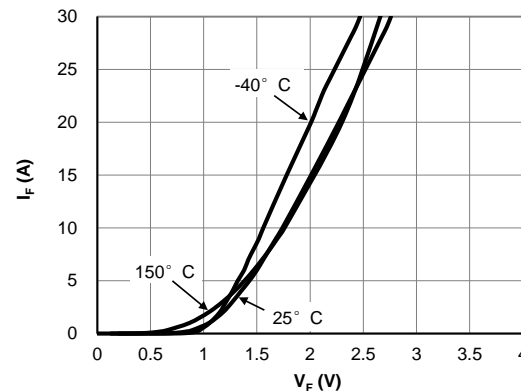
**Figure 1: Output Characteristic**  
( $T_j=25^\circ\text{C}$ )



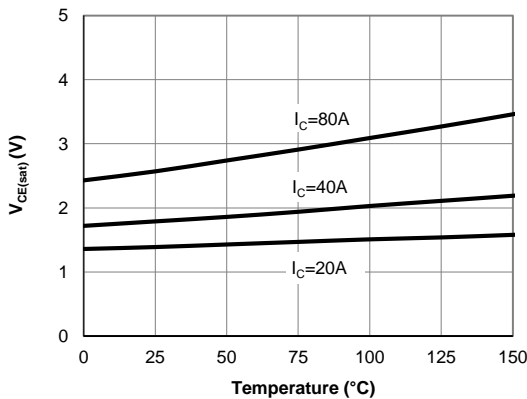
**Figure 2: Output Characteristic**  
( $T_j=150^\circ\text{C}$ )



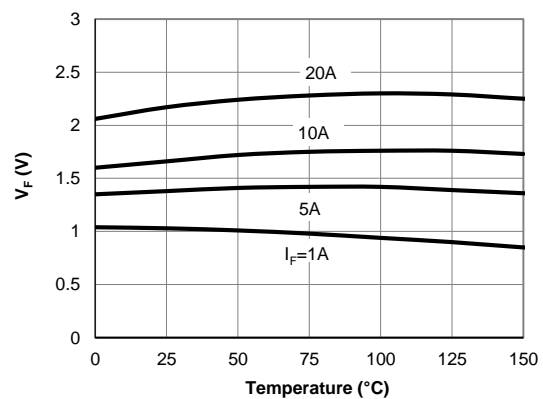
**Figure 3: Transfer Characteristic**



**Figure 4: Diode Characteristic**

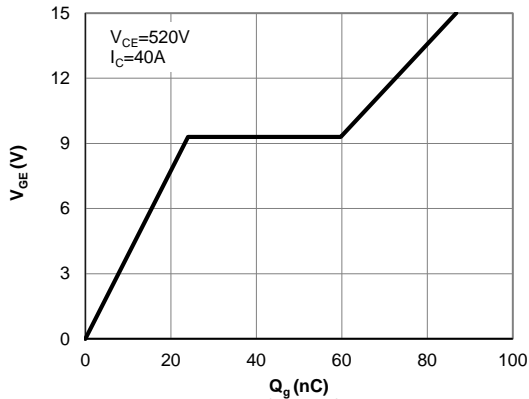


**Figure 5: Collector-Emitter Saturation Voltage vs. Junction Temperature**

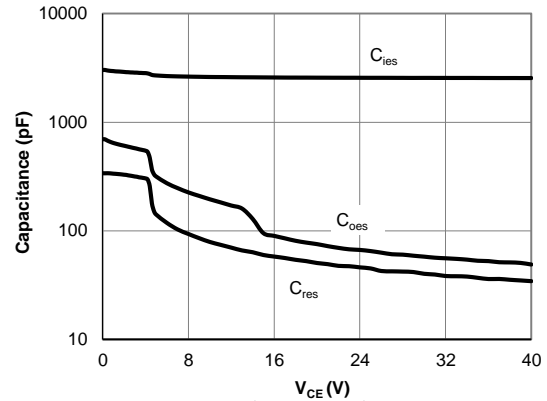


**Figure 6: Diode Forward voltage vs. Junction Temperature**

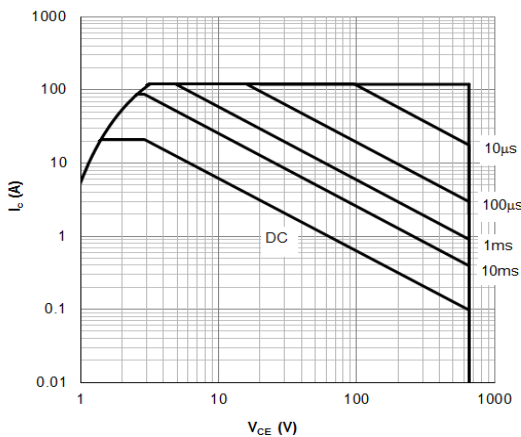
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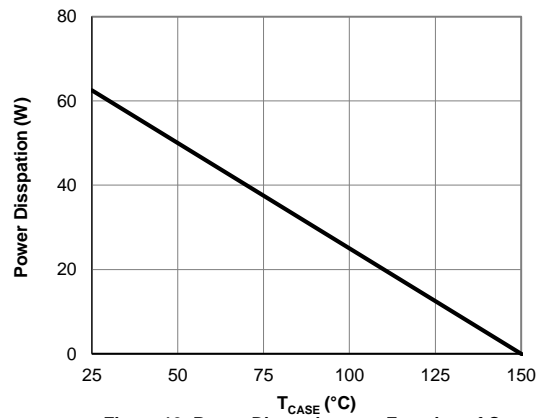
**Figure 7: Gate-Charge Characteristics**



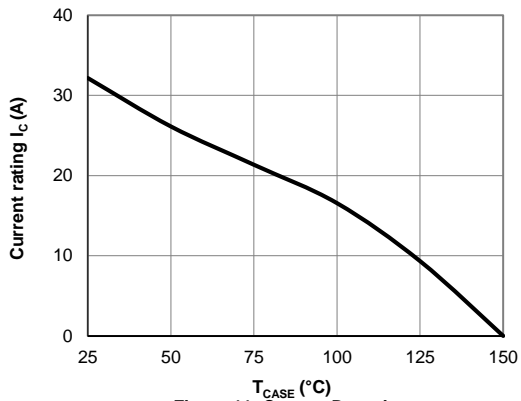
**Figure 8: Capacitance Characteristic**



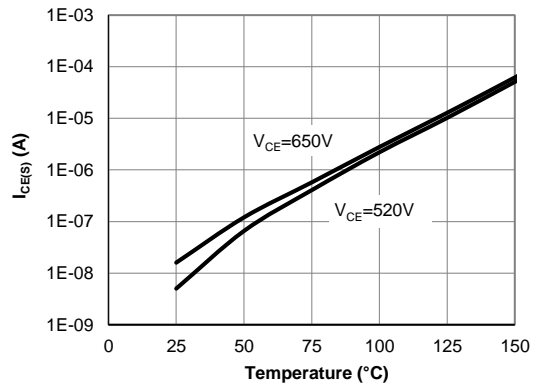
**Figure 9: Forward Bias Safe Operating Area**  
( $T_C=25^\circ\text{C}$ ,  $V_{GE}=15\text{V}$ )



**Figure 10: Power Dissipation as a Function of Case**

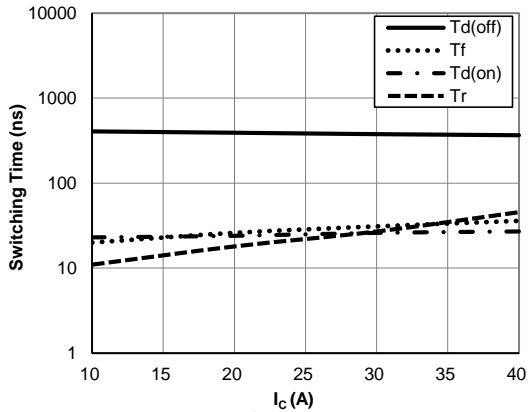


**Figure 11: Current De-rating**

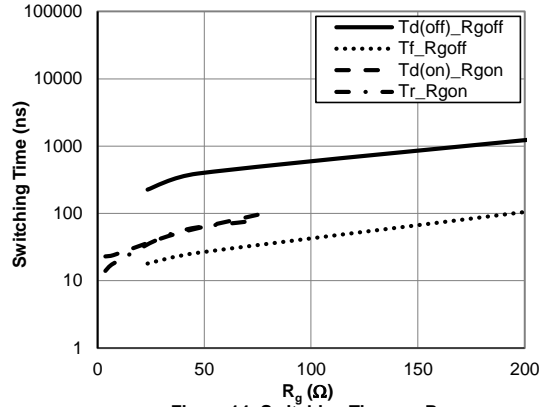


**Figure 12: Diode Reverse Leakage Current vs. Junction Temperature**

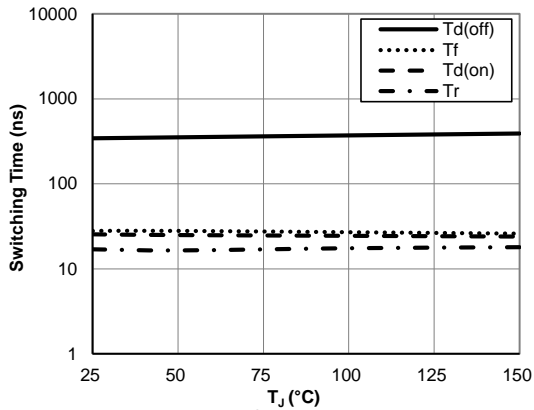
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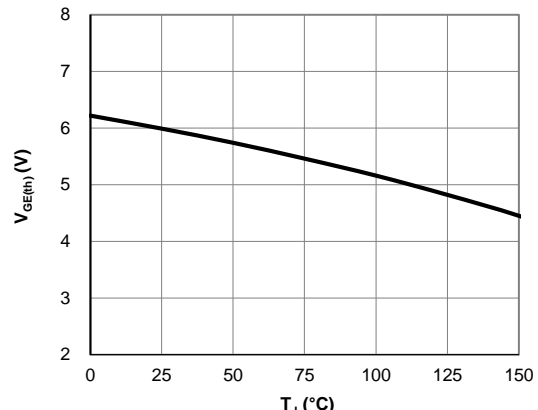
**Figure 13: Switching Time vs.  $I_C$**   
( $T_J=150^{\circ}\text{C}$ ,  $V_{GE}=15\text{V}$ ,  $V_{CE}=400\text{V}$ ,  $R_{gon}=7.5\Omega$ ,  $R_{goff}=47\Omega$ )



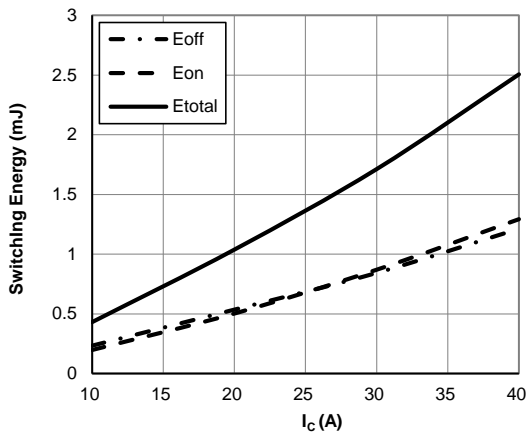
**Figure 14: Switching Time vs.  $R_g$**   
( $T_J=150^{\circ}\text{C}$ ,  $V_{GE}=15\text{V}$ ,  $V_{CE}=400\text{V}$ ,  $I_C=20\text{A}$ )



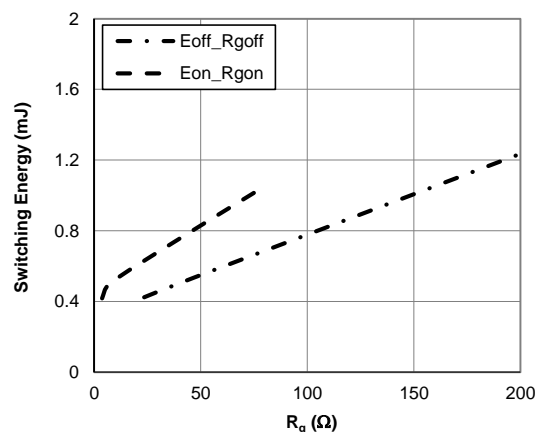
**Figure 15: Switching Time vs.  $T_J$**   
( $V_{GE}=15\text{V}$ ,  $V_{CE}=400\text{V}$ ,  $I_C=20\text{A}$ ,  $R_{gon}=7.5\Omega$ ,  $R_{goff}=47\Omega$ )



**Figure 16:  $V_{GE(th)}$  vs.  $T_J$**

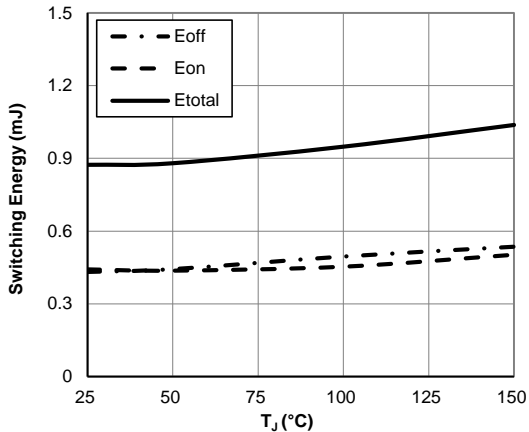


**Figure 17: Switching Loss vs.  $I_C$**   
( $T_J=150^{\circ}\text{C}$ ,  $V_{GE}=15\text{V}$ ,  $V_{CE}=400\text{V}$ ,  $R_{gon}=7.5\Omega$ ,  $R_{goff}=47\Omega$ )

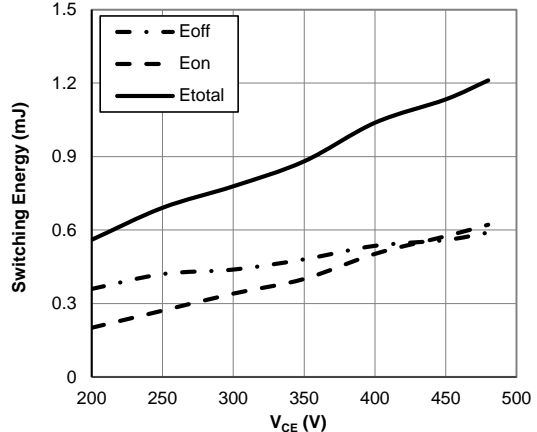


**Figure 18: Switching Loss vs.  $R_g$**   
( $T_J=150^{\circ}\text{C}$ ,  $V_{GE}=15\text{V}$ ,  $V_{CE}=400\text{V}$ ,  $I_C=20\text{A}$ )

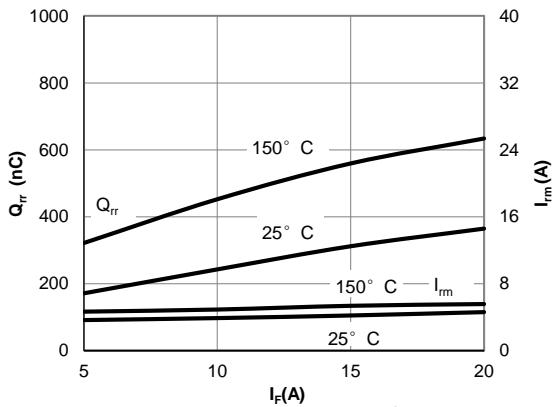
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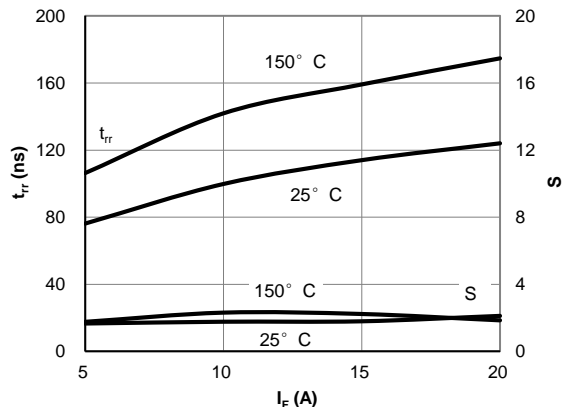
**Figure 19: Switching Loss vs.  $T_j$**   
( $V_{GE}=15V, V_{CE}=400V, I_C=20A, R_{gon}=7.5\Omega, R_{goff}=47\Omega$ )



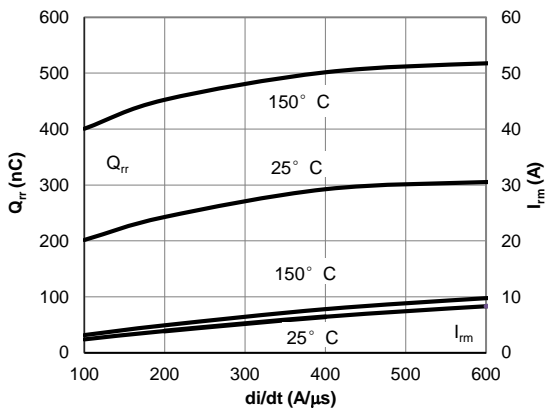
**Figure 20: Switching Loss vs.  $V_{CE}$**   
( $T_j=150^\circ C, V_{GE}=15V, I_C=20A, R_{gon}=7.5\Omega, R_{goff}=47\Omega$ )



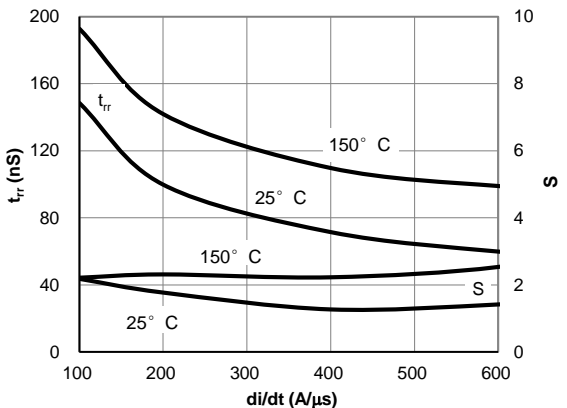
**Figure 21: Diode Reverse Recovery Charge and Peak Current vs. Conduction Current**  
( $V_{GE}=15V, V_{CE}=400V, di/dt=200A/\mu s$ )



**Figure 22: Diode Reverse Recovery Time and Softness Factor vs. Conduction Current**  
( $V_{GE}=15V, V_{CE}=400V, di/dt=200A/\mu s$ )

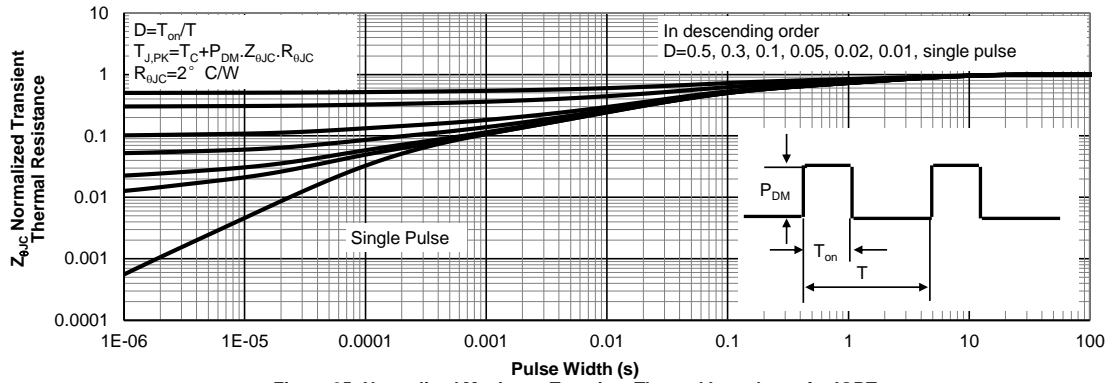


**Figure 23: Diode Reverse Recovery Charge and Peak Current vs.  $di/dt$**   
( $V_{GE}=15V, V_{CE}=400V, I_F=10A$ )

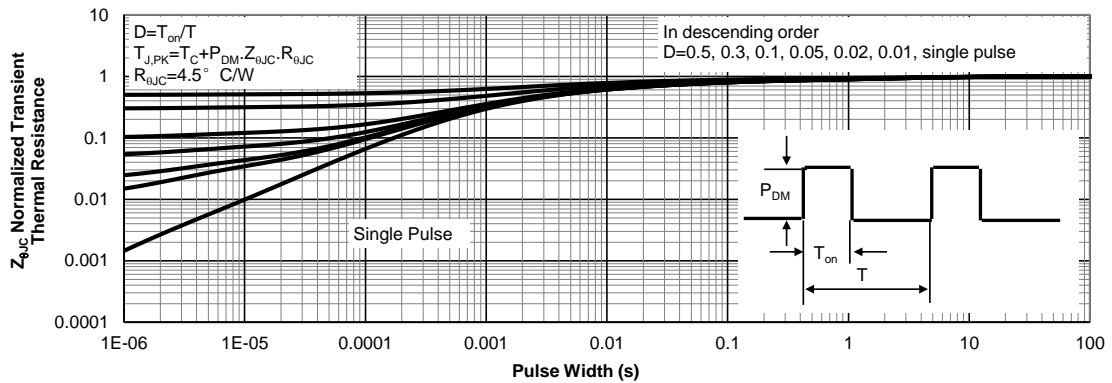


**Figure 24: Diode Reverse Recovery Time and Softness Factor vs.  $di/dt$**   
( $V_{GE}=15V, V_{CE}=400V, I_F=10A$ )

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



**Figure 25: Normalized Maximum Transient Thermal Impedance for IGBT**



**Figure 26: Normalized Maximum Transient Thermal Impedance for Diode**

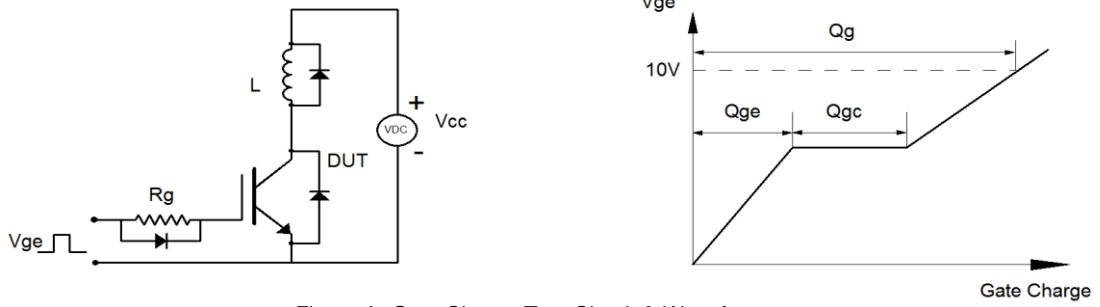


Figure A: Gate Charge Test Circuit & Waveforms

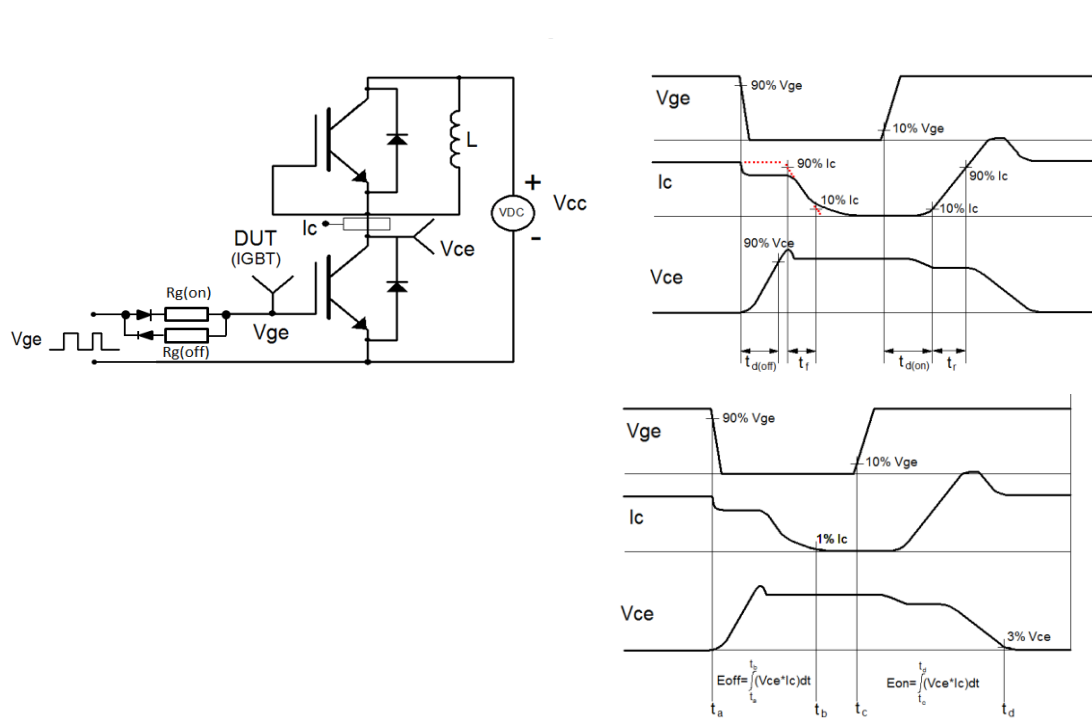


Figure B: Inductive Switching Test Circuit & Waveforms

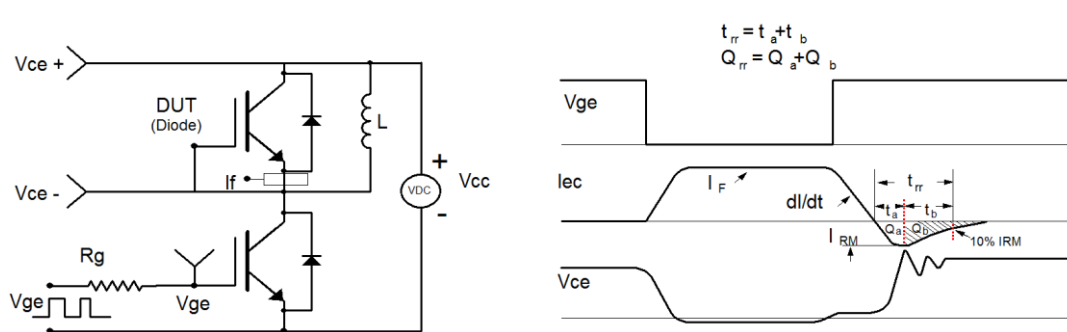


Figure C: Diode Recovery Test Circuit & Waveforms